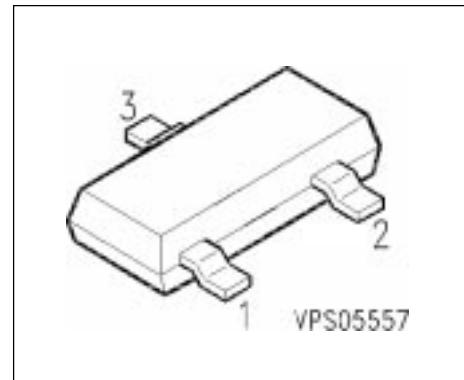


SIPMOS® Small-Signal Transistor

- P channel
- Enhancement mode
- Logic Level
- $V_{GS(th)} = -0.8\ldots-2.0 \text{ V}$



Pin 1	Pin 2	Pin 3
G	S	D

Type	V_{DS}	I_D	$R_{DS(on)}$	Package	Marking
BSS 84	-50 V	-0.13 A	10 Ω	SOT-23	SPs
Type	Ordering Code		Tape and Reel Information		
BSS 84	Q62702-S568		E6327		
BSS 84	Q67000-S243		E6433		

Maximum Ratings

Parameter	Symbol	Values	Unit
Drain source voltage	V_{DS}	-50	V
Drain-gate voltage $R_{GS} = 20 \text{ k}\Omega$	V_{DGR}	-50	
Gate source voltage	V_{GS}	± 20	
Continuous drain current $T_A = 30^\circ \text{C}$	I_D	-0.13	
DC drain current, pulsed $T_A = 25^\circ \text{C}$	I_{Dpuls}	-0.52	A
Power dissipation $T_A = 25^\circ \text{C}$	P_{tot}	0.36	W

Maximum Ratings

Parameter	Symbol	Values	Unit
Chip or operating temperature	T_j	-55 ... + 150	°C
Storage temperature	T_{stg}	-55 ... + 150	
Thermal resistance, chip to ambient air ¹⁾	R_{thJA}	≤ 350	K/W
Thermal resistance, chip-substrate- reverse side ¹⁾	R_{thJSR}	≤ 285	
DIN humidity category, DIN 40 040		E	
IEC climatic category, DIN IEC 68-1		55 / 150 / 56	

1) For package mounted on aluminium 15 mm x 16.7 mm x 0.7 mm

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Static Characteristics

Drain- source breakdown voltage $V_{GS} = 0 \text{ V}, I_D = -0.25 \text{ mA}, T_j = 25^\circ\text{C}$	$V_{(BR)DSS}$	-50	-	-	V
Gate threshold voltage $V_{GS} = V_{DS}, I_D = -1 \text{ mA}$	$V_{GS(th)}$	-0.8	-1.5	-2	
Zero gate voltage drain current $V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25^\circ\text{C}$	I_{DSS}	-	-0.1	-1	μA
$V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 125^\circ\text{C}$		-	-2	-60	
$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25^\circ\text{C}$		-	-	-0.1	
Gate-source leakage current $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$	I_{GSS}	-	-1	-10	nA
Drain-Source on-state resistance $V_{GS} = -10 \text{ V}, I_D = -0.13 \text{ A}$	$R_{DS(on)}$	-	5	10	Ω

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Dynamic Characteristics

Transconductance $V_{DS} \geq 2 * I_D * R_{DS(on)max}$, $I_D = -0.13 \text{ A}$	g_{fs}	0.05	0.085	-	S
Input capacitance $V_{GS} = 0 \text{ V}$, $V_{DS} = -25 \text{ V}$, $f = 1 \text{ MHz}$	C_{iss}	-	30	40	pF
Output capacitance $V_{GS} = 0 \text{ V}$, $V_{DS} = -25 \text{ V}$, $f = 1 \text{ MHz}$	C_{oss}	-	17	25	
Reverse transfer capacitance $V_{GS} = 0 \text{ V}$, $V_{DS} = -25 \text{ V}$, $f = 1 \text{ MHz}$	C_{rss}	-	8	12	
Turn-on delay time $V_{DD} = -30 \text{ V}$, $V_{GS} = -10 \text{ V}$, $I_D = -0.27 \text{ A}$ $R_{GS} = 50 \Omega$	$t_{d(on)}$	-	7	10	ns
Rise time $V_{DD} = -30 \text{ V}$, $V_{GS} = -10 \text{ V}$, $I_D = -0.27 \text{ A}$ $R_{GS} = 50 \Omega$	t_r	-	12	18	
Turn-off delay time $V_{DD} = -30 \text{ V}$, $V_{GS} = -10 \text{ V}$, $I_D = -0.27 \text{ A}$ $R_{GS} = 50 \Omega$	$t_{d(off)}$	-	10	13	
Fall time $V_{DD} = -30 \text{ V}$, $V_{GS} = -10 \text{ V}$, $I_D = -0.27 \text{ A}$ $R_{GS} = 50 \Omega$	t_f	-	20	27	

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

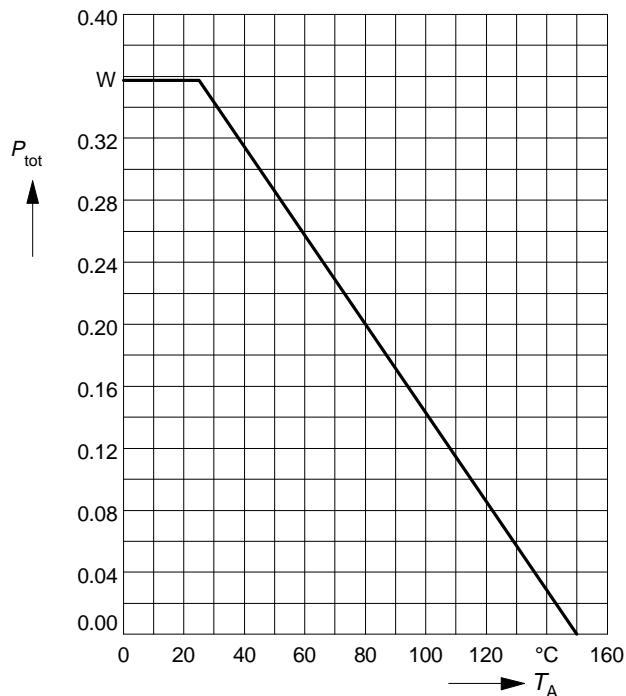
Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Reverse Diode

Inverse diode continuous forward current $T_A = 25^\circ\text{C}$	I_S	-	-	-0.13	A
Inverse diode direct current,pulsed $T_A = 25^\circ\text{C}$	I_{SM}	-	-	-0.52	
Inverse diode forward voltage $V_{GS} = 0 \text{ V}, I_F = -0.26 \text{ A}, T_j = 25^\circ\text{C}$	V_{SD}	-	-0.9	-1.2	V

Power dissipation

$$P_{\text{tot}} = f(T_A)$$



Drain current

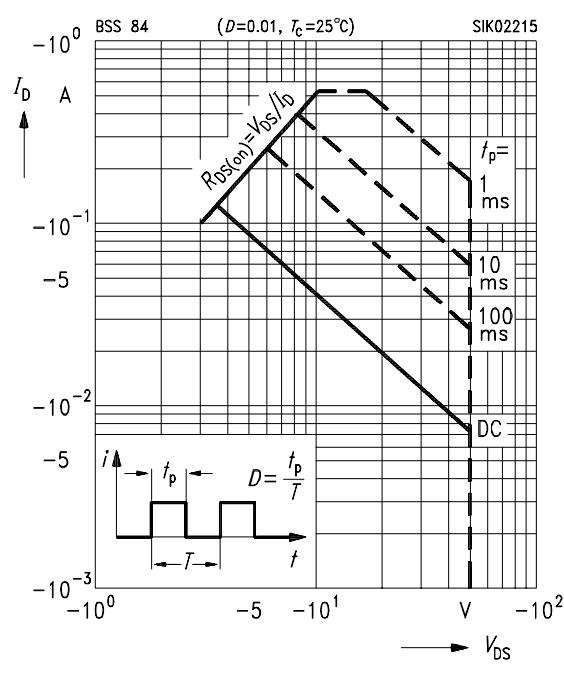
$$I_D = f(T_A)$$

parameter: $V_{GS} \geq -10$ V



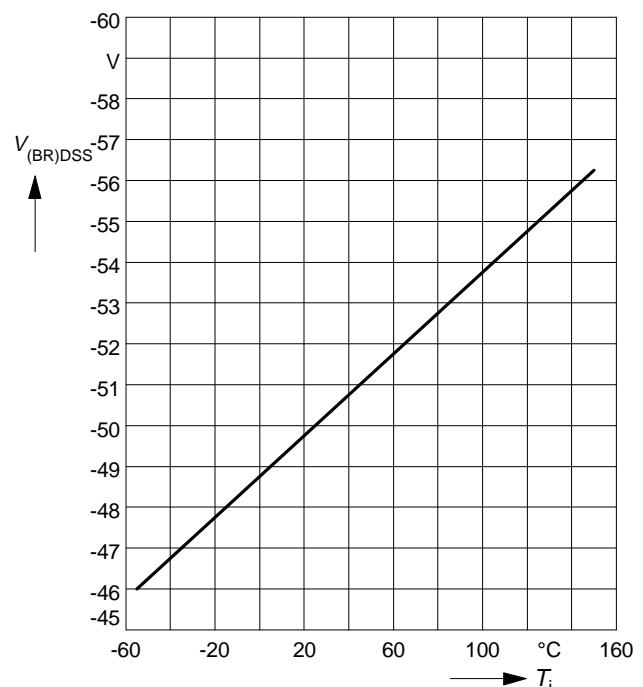
Safe operating area $I_D=f(V_{DS})$

parameter : $D = 0.01$, $T_C=25^\circ\text{C}$



Drain-source breakdown voltage

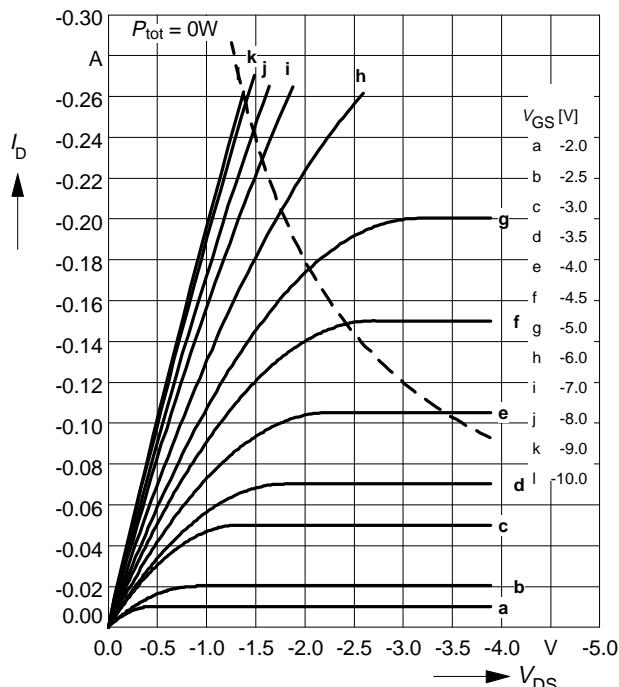
$$V_{(\text{BR})DSS} = f(T_j)$$



Typ. output characteristics

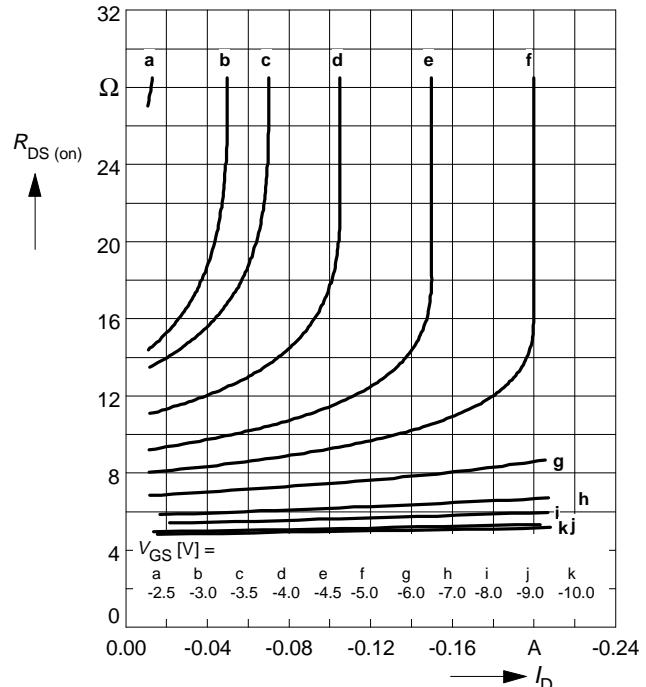
$$I_D = f(V_{DS})$$

parameter: $t_p = 80 \mu\text{s}$, $T_j = 25^\circ\text{C}$


Typ. drain-source on-resistance

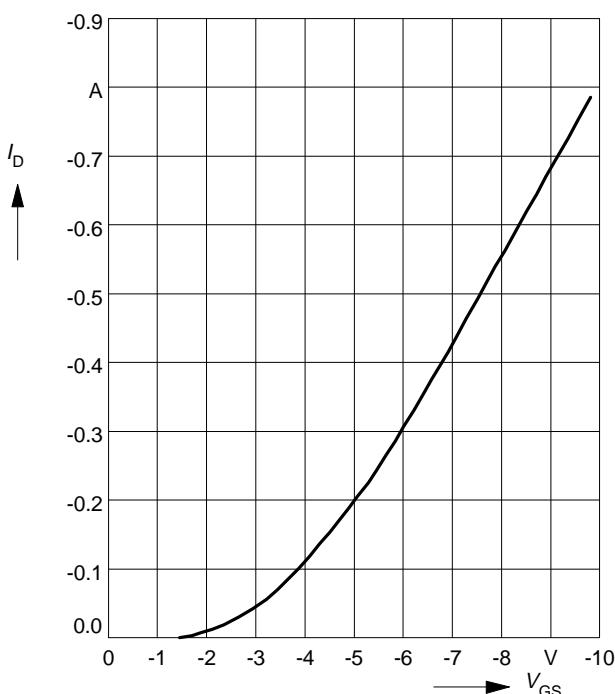
$$R_{DS(\text{on})} = f(I_D)$$

parameter: $t_p = 80 \mu\text{s}$, $T_j = 25^\circ\text{C}$


Typ. transfer characteristics $I_D = f(V_{GS})$

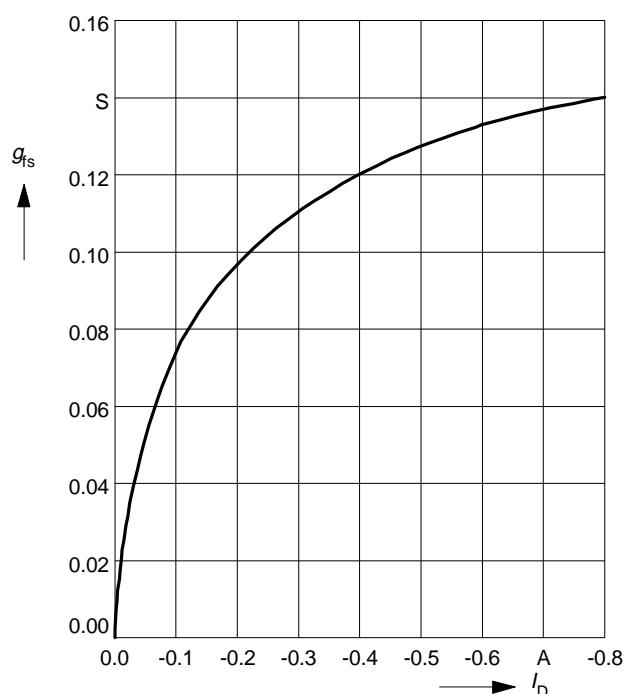
parameter: $t_p = 80 \mu\text{s}$

$$V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max}}$$


Typ. forward transconductance $g_{fs} = f(I_D)$

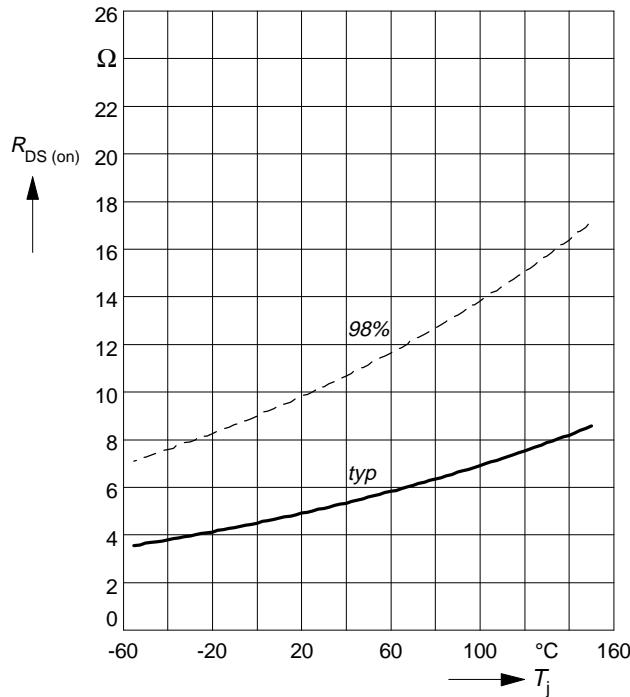
parameter: $t_p = 80 \mu\text{s}$,

$$V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max}}$$



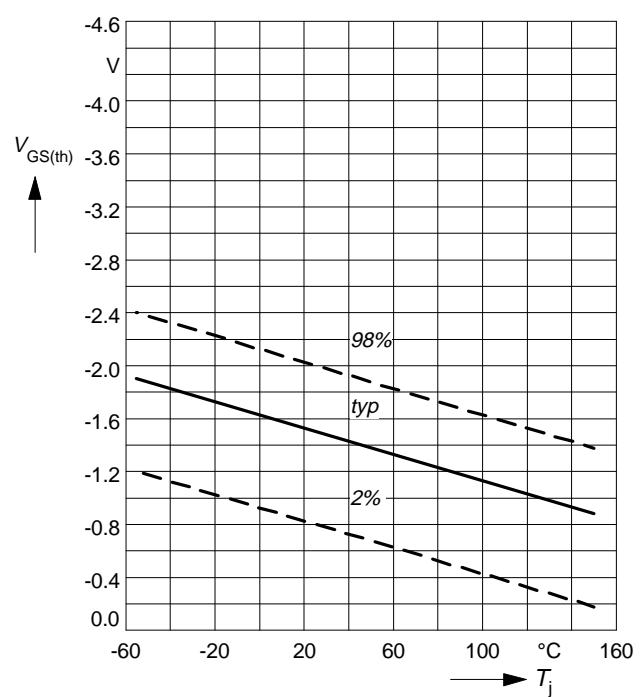
Drain-source on-resistance

$R_{DS(on)} = f(T_j)$
parameter: $I_D = -0.13 \text{ A}$, $V_{GS} = -10 \text{ V}$



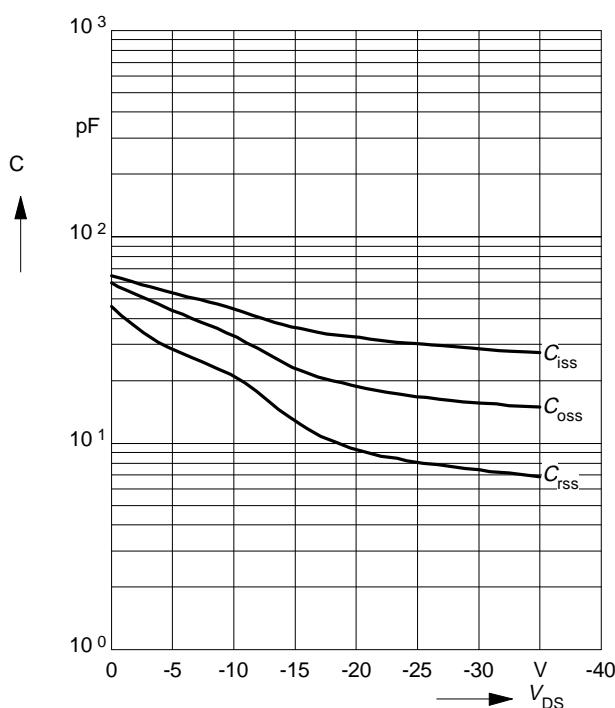
Gate threshold voltage

$V_{GS(th)} = f(T_j)$
parameter: $V_{GS} = V_{DS}$, $I_D = -1 \text{ mA}$



Typ. capacitances

$C = f(V_{DS})$
parameter: $V_{GS}=0\text{V}$, $f = 1 \text{ MHz}$



Forward characteristics of reverse diode

$I_F = f(V_{SD})$
parameter: T_j , $t_p = 80 \mu\text{s}$

